

Sheet 1 of 1

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)

Date Submitted to PTO: October 7, 2003

ATTY DOCKET NO.  
2003\_0919A

SERIAL NO.  
10/611,867

APPLICANT  
Tomohiro OKUMURA et al.

FILING DATE  
July 3, 2003

GROUP  
2812

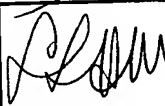
U.S. PATENT DOCUMENTS

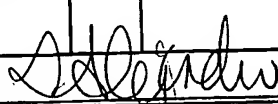
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
	AJ							
	AK							
	AL							
	AM							
	AN							

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO	B. Mizuno et al., "NEW DOPING METHOD FOR SUBHALF MICRON TRENCH SIDEWALLS BY USING AN ELECTRON CYCLOTRON RESONANCE PLASMA", Applied Physics Letters, Vol. 53, No. 21, November 1998, pages 2059-2061, published by American Institute of Physics.
	AP	
	AQ	

EXAMINER 

DATE CONSIDERED 10/31/05

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of form with next communication to applicant.